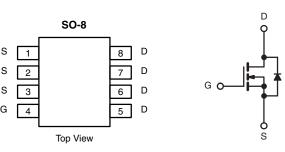


# **VS1H18AS-VB** Datasheet

# N-Channel 100-V (D-S) Super Trench Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ ) Max.	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)		
	0.0082 at V <sub>GS</sub> = 10 V	15.5			
100	0.0095 at V <sub>GS</sub> = 7.5 V	14.8	27.9 nC		
	0.0105 at V <sub>GS</sub> = 6.0 V	14.0			



#### N-Channel MOSFET

#### **FEATURES**

- Super Trench technology Power MOSFET
- Excellent gate charge x Rds (on) product(FOM)
- Very low on-resfistance Rds (on)
- 100 % R<sub>g</sub> and UIS Tested



ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- DC/DC Primary Side Switch
- Telecom/Server
- Motor Drive Control
- Synchronous Rectification

<b>ABSOLUTE MAXIMUM RATIN</b>	IGS (T <sub>A</sub> = 25 °C	, unless oth	erwise noted)	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		$V_{DS}$	100	V
Gate-Source Voltage		$V_{GS}$	± 20	v
	T <sub>C</sub> = 25 °C		15.5	
Continuous Proin Current (T = 150 °C)	T <sub>C</sub> = 70 °C	1	13	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	10.2 <sup>b, c</sup>	
	T <sub>A</sub> = 70 °C		7.4 <sup>b, c</sup>	A
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub>	70	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	Is	7	7
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C		3.1 <sup>b, c</sup>	
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	30	
Avalanche Energy	L = 0.1 mH		45	mJ
	T <sub>C</sub> = 25 °C		7.8	
Maximum Power Dissipation	T <sub>C</sub> = 70 °C		5	W
Maximum Fower Dissipation	T <sub>A</sub> = 25 °C	- P <sub>D</sub>	3.5 <sup>b, c</sup>	T vv
	T <sub>A</sub> = 70 °C		2.2 <sup>b, c</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	29	35	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	13	16	] 0,11	

#### Notes:

- a. Based on  $T_C$  = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under steady state conditions is 80 °C/W.



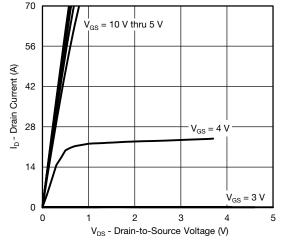
SPECIFICATIONS (T <sub>J</sub> = 25 °C			NA:	T	Merr	11	
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	.,	V 0.V 1 050 A		T	T	T	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100			V	
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA		67		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	_		- 6.4			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	2		3.3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V	55 °C 10		1	μΑ	
Zoro dato voltago Brain Garroni	-033	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current <sup>a</sup>	$I_{D(on)}$	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
		$V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$		0.0082			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, I_D = 12 \text{ A}$		0.0095		Ω	
		$V_{GS} = 6.0 \text{ V}, I_D = 10 \text{ A}$		0.0105			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A		54		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			3410			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V, f = 1 MHz		790		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>	1 50 90		160			
· ·		V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		45.6	69	+	
Total Gate Charge	Q <sub>g</sub> V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 X		27.9	42	-		
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 6 V, I <sub>D</sub> = 10 A		8.5		nC	
Gate-Drain Charge	Q <sub>gd</sub>			9.2			
Output Charge	Q <sub>oss</sub>	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0 V		63	95	1	
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.4	1.3	2.6	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			16	32		
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_1 = 5 \Omega$		11	22		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 7.5 \text{ V}, R_q = 1 \Omega$		35	70		
Fall Time	t <sub>f</sub>	_		10	20		
Turn-On Delay Time	t <sub>d(on)</sub>			14	28	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_1 = 5 \Omega$		10	20	- - -	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_q = 1 \Omega$		36	70		
Fall Time	t <sub>f</sub>	<u></u>		10	20		
Drain-Source Body Diode Characteristi						<u> </u>	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			7		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				70	Α	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A		0.75	1.1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>	.3 57.		49	95	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	1		58	115	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 \text{ °C}$		21	110	110	
Reverse Recovery Rise Time				28		ns	
otes:	t <sub>b</sub>			20		<u> </u>	

#### Notes:

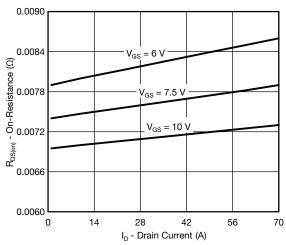
- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

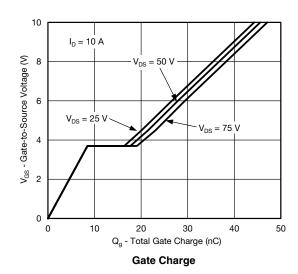


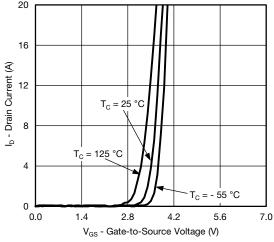


#### **Output Characteristics**

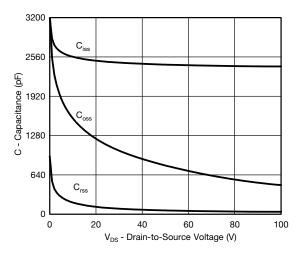


On-Resistance vs. Drain Current

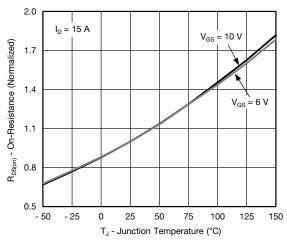




Transfer Characteristics

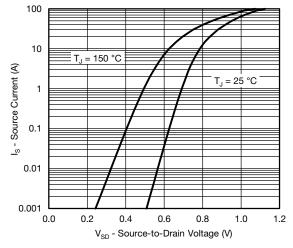


Capacitance

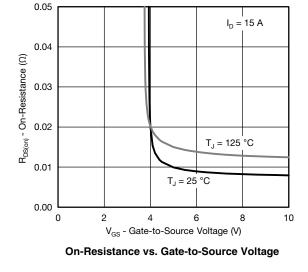


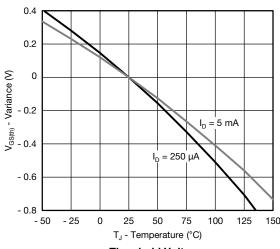
On-Resistance vs. Junction Temperature



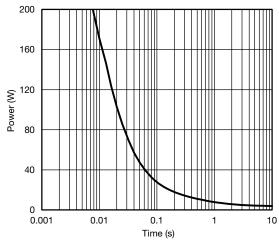


Source-Drain Diode Forward Voltage

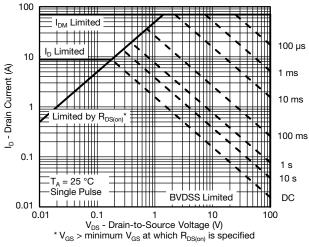




**Threshold Voltage** 

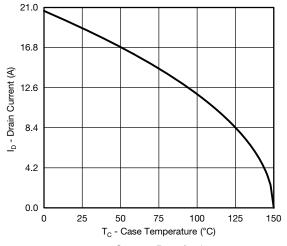


Single Pulse Power, Junction-to-Ambient

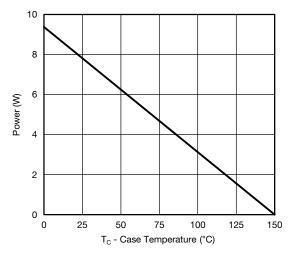


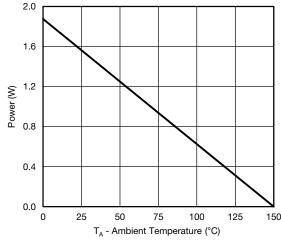
Safe Operating Area, Junction-to-Ambient





#### **Current Derating\***





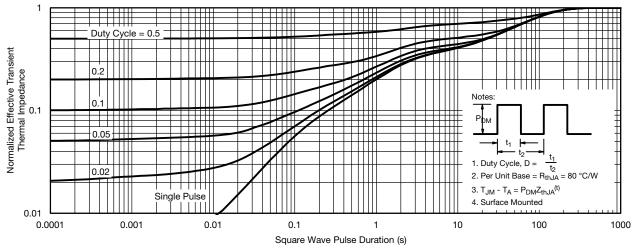
Power, Junction-to-Foot

Power, Junction-to-Ambient

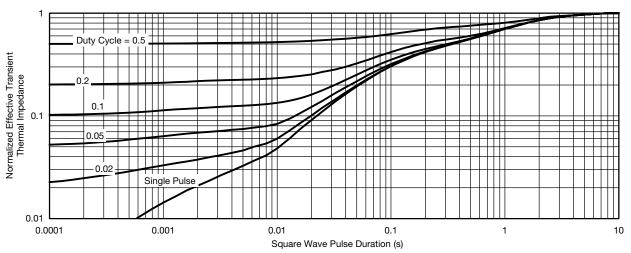
5

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





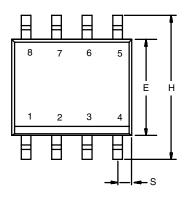
Normalized Thermal Transient Impedance, Junction-to-Ambient

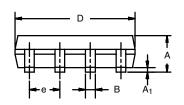


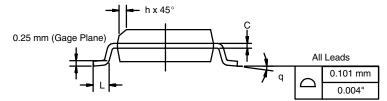
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







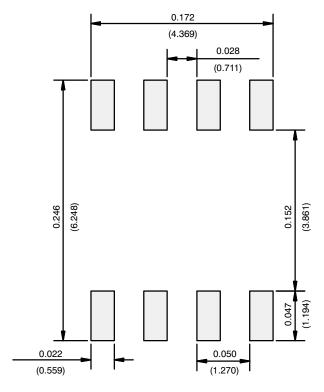
	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A <sub>1</sub>	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050 BSC			
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I, 11-Sep-06						

DWG: 5498

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## **RECOMMENDED MINIMUM PADS FOR SO-8**



Recommended Minimum Pads Dimensions in Inches/(mm)



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